



Parameter	Rating	Units
Blocking Voltage	350	$V_P$
Load Current	100	mA
Max On-Resistance	50	$\Omega$

### Features

- 3750V<sub>rms</sub> Input/Output Isolation
- Low Drive Power Requirements (TTL/CMOS Compatible)
- FCC Compatible
- VDE Compatible
- No Moving Parts
- High Reliability
- Arc-Free With No Snubbing Circuits
- No EMI/RFI Generation
- Small 8-Pin Package
- Machine Insertable, Wave Solderable
- Surface Mount and Tape & Reel Versions Available

### Applications

- Telecommunications
  - Telecom Switching
  - Tip/Ring Circuits
  - Modem Switching (Laptop, Notebook, Pocket Size)
  - Hook Switch
  - Dial Pulsing
  - Ground Start
  - Ringing Injection
- Instrumentation
  - Multiplexers
  - Data Acquisition
  - Electronic Switching
  - I/O Subsystems
  - Meters (Watt-Hour, Water, Gas)
- Medical Equipment-Patient/Equipment Isolation
- Security
- Aerospace
- Industrial Controls

### Description

The XS170 integrated circuit device combines a 350V, 100mA, 50 $\Omega$ , normally open (1-Form-A) relay with an optocoupler in a single package. The relay uses optically coupled MOSFET technology to provide 3750V<sub>rms</sub> of input to output isolation. The efficient MOSFET switches and photovoltaic die use Clare's patented OptoMOS® architecture, in which highly efficient GaAIAs infrared LEDs control the optically coupled output.

Telecom circuit designers, using the XS170, can now take advantage of two discrete functions in a single component that uses less space than traditional discrete component solutions.

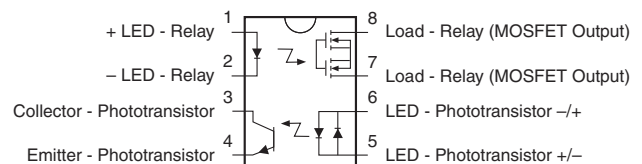
### Approvals

- UL Recognized Component: File E76270
- CSA Certified Component: Certificate 1175739
- EN/IEC 60950 Certified Component:  
TUV Certificate: B 10 05 49410 006

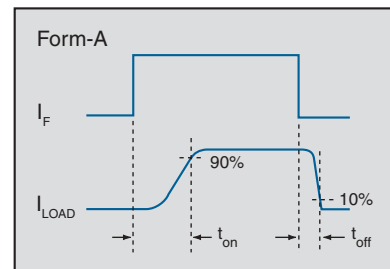
### Ordering Information

Part #	Description
XS170	8-Pin DIP (50/Tube)
XS170S	8-Pin Surface Mount (50/Tube)
XS170STR	8-Pin Surface Mount (1000/Reel)

### Pin Configuration



### Switching Characteristics of Normally Open Devices



### Absolute Maximum Ratings @ 25°C

Parameter	Ratings	Units
Relay Blocking Voltage	350	V <sub>P</sub>
Reverse Input Voltage	5	V
Input Power Dissipation <sup>1</sup>	150	mW
Relay Input Control Current	50	mA
Peak (10ms)	1	A
Detector Input Control Current	100	mA
Total Power Dissipation <sup>2</sup>	800	mW
Isolation Voltage, Input to Output	3750	V <sub>rms</sub>
Operational Temperature	-40 to +85	°C
Storage Temperature	-40 to +125	°C

<sup>1</sup> Derate linearly 1.33 mW / °C

<sup>2</sup> Derate linearly 6.67 mW / °C

*Absolute Maximum Ratings are stress ratings. Stresses in excess of these ratings can cause permanent damage to the device. Functional operation of the device at conditions beyond those indicated in the operational sections of this data sheet is not implied.*

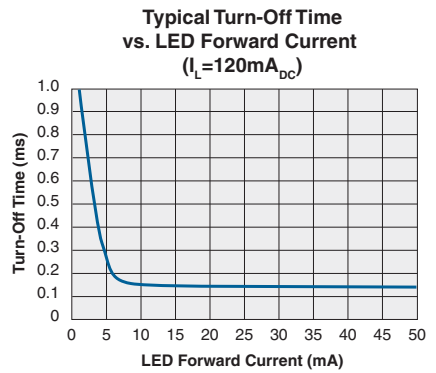
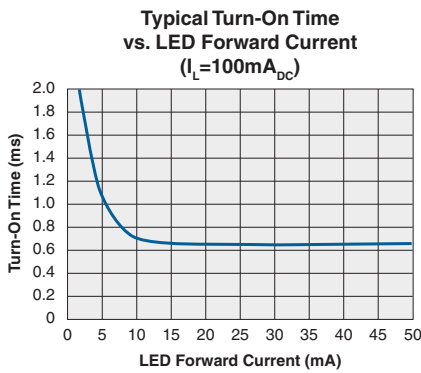
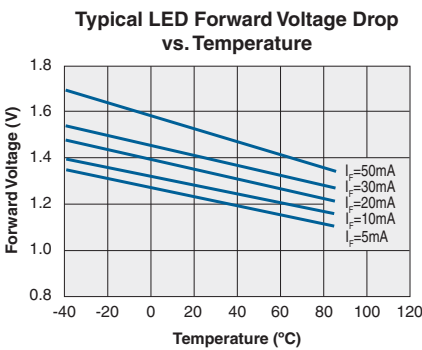
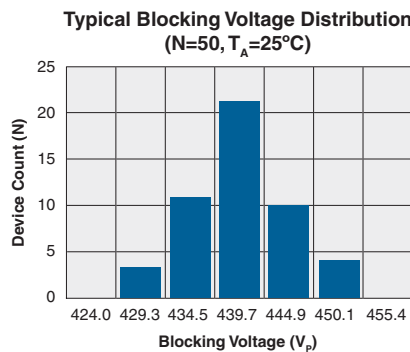
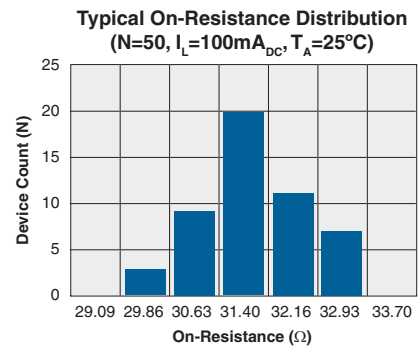
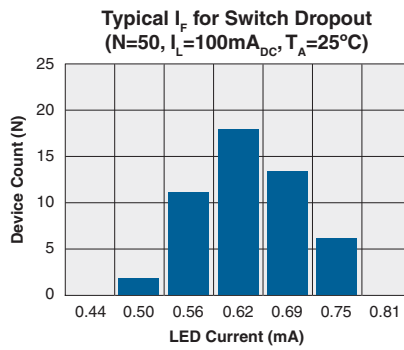
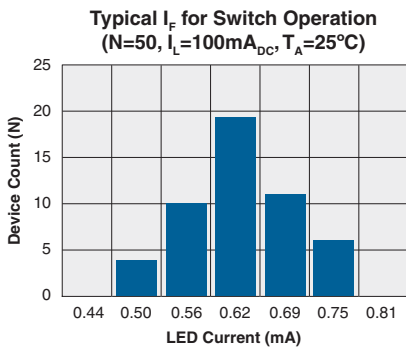
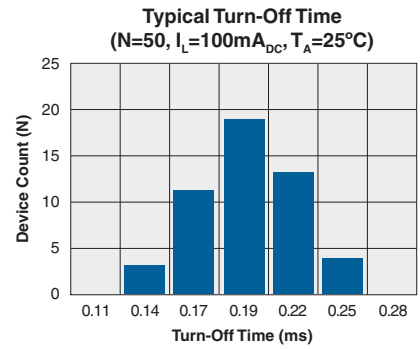
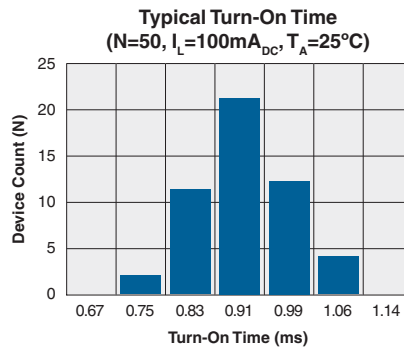
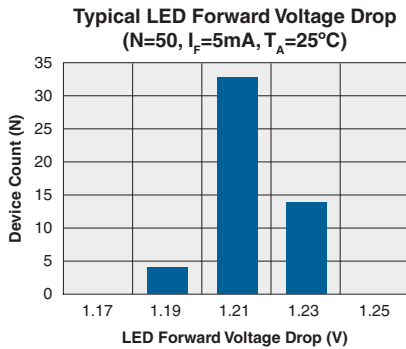
### Electrical Characteristics @25°C: Relay Section

Parameter	Conditions	Symbol	Min	Typ	Max	Units
<b>Output Characteristics</b>						
Load Current, Continuous	-	I <sub>L</sub>	-	-	100	mA
Peak	t=10ms	I <sub>LPK</sub>	-	-	350	
On-Resistance	I <sub>L</sub> =120mA	R <sub>ON</sub>	-	33	50	Ω
Off-State Leakage Current	V <sub>L</sub> =350V	I <sub>LEAK</sub>	-	-	1	μA
<b>Switching Speeds</b>						
Turn-On	I <sub>F</sub> =5mA, V <sub>L</sub> =10V	t <sub>on</sub>	-	-	5	ms
Turn-Off		t <sub>off</sub>	-	-	5	
Output Capacitance	V <sub>L</sub> =50V, f=1MHz	C <sub>OUT</sub>	-	25	-	pF
<b>Input Characteristics</b>						
Input Control Current to Activate	I <sub>L</sub> =120mA	I <sub>F</sub>	-	-	2	mA
Input Control Current to Deactivate	-	I <sub>F</sub>	0.4	0.7	-	mA
Input Voltage Drop	I <sub>F</sub> =5mA	V <sub>F</sub>	0.9	1.2	1.4	V
Reverse Input Current	V <sub>R</sub> =5V	I <sub>R</sub>	-	-	10	μA
<b>Common Characteristics</b>						
Input to Output Capacitance	-	C <sub>I/O</sub>	-	3	-	pF

### Electrical Characteristics @25°C: Detector Section

Parameter	Conditions	Symbol	Min	Typ	Max	Units
<b>Output Characteristics</b>						
Phototransistor Blocking Voltage	I <sub>C</sub> =10μA	BV <sub>CEO</sub>	20	50	-	V
Phototransistor Dark Current	V <sub>CE</sub> =5V, I <sub>F</sub> =0mA	I <sub>CEO</sub>	-	50	500	nA
Saturation Voltage	I <sub>C</sub> =2mA, I <sub>F</sub> =16mA	V <sub>SAT</sub>	-	0.3	0.5	V
Current Transfer Ratio	I <sub>F</sub> =6mA, V <sub>CE</sub> =0.5V	CTR	33	100	-	%
<b>Input Characteristics</b>						
Input Control Current	I <sub>C</sub> =2mA, V <sub>CE</sub> =0.5V	I <sub>F</sub>	-	2	6	mA
Input Voltage Drop	I <sub>F</sub> =5mA	V <sub>F</sub>	0.9	1.2	1.4	V
Input Current (Detector must be off)	I <sub>C</sub> =1μA, V <sub>CE</sub> =5V	I <sub>F</sub>	5	25	-	μA
Isolation, Input to Output	-	V <sub>I/O</sub>	3750	-	-	V <sub>rms</sub>
<b>Common Characteristics</b>						
Input to Output Capacitance	-	C <sub>I/O</sub>	-	3	-	pF

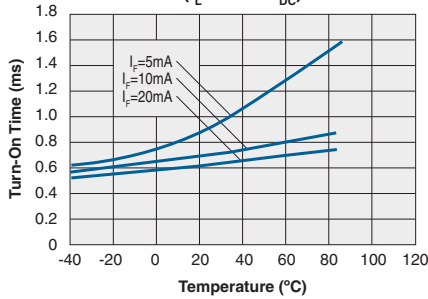
**PERFORMANCE DATA: RELAY**



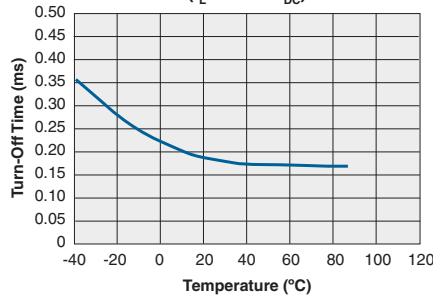
\* The Performance data shown in the graphs above is typical of device performance. For guaranteed parameters not indicated in the written specifications, please contact our application department.

**PERFORMANCE DATA: RELAY (cont.)**

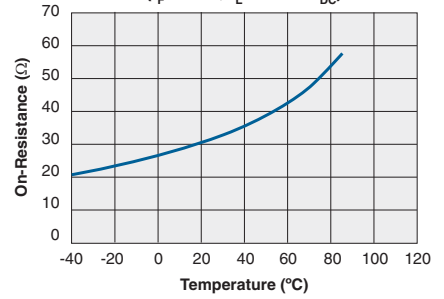
**Typical Turn-On Time vs. Temperature**  
( $I_L=100\text{mA}_{DC}$ )



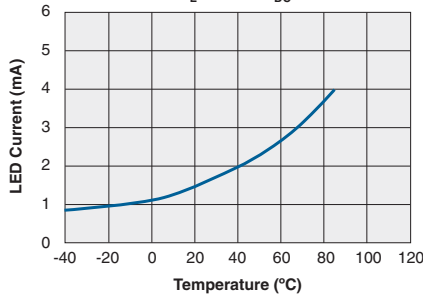
**Typical Turn-Off Time vs. Temperature**  
( $I_L=120\text{mA}_{DC}$ )



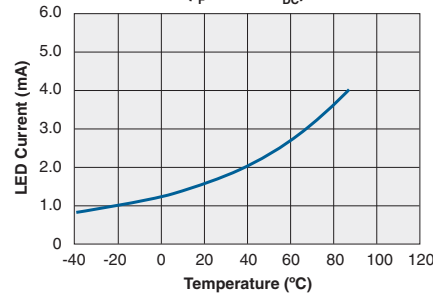
**Typical On-Resistance vs. Temperature**  
( $I_F=5\text{mA}$ ,  $I_L=100\text{mA}_{DC}$ )



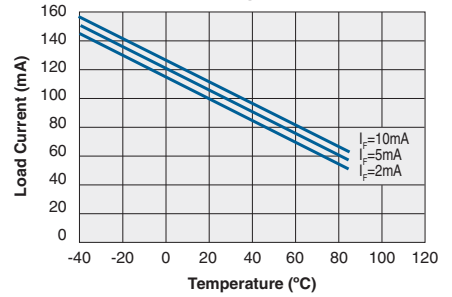
**Typical  $I_F$  for Switch Operation vs. Temperature**  
( $I_L=100\text{mA}_{DC}$ )



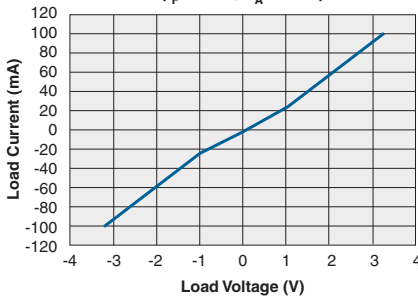
**Typical  $I_F$  for Switch Dropout vs. Temperature**  
( $I_F=100\text{mA}_{DC}$ )



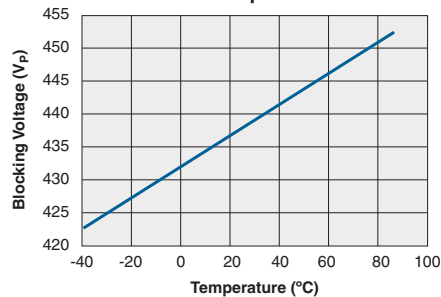
**Typical Load Current vs. Temperature**



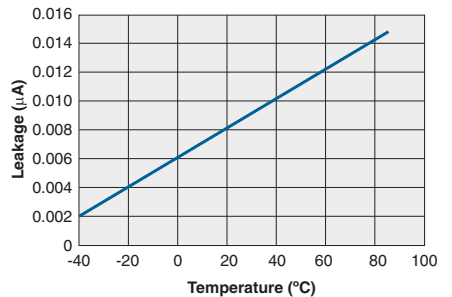
**Typical Load Current vs. Load Voltage**  
( $I_F=5\text{mA}$ ,  $T_A=25^\circ\text{C}$ )



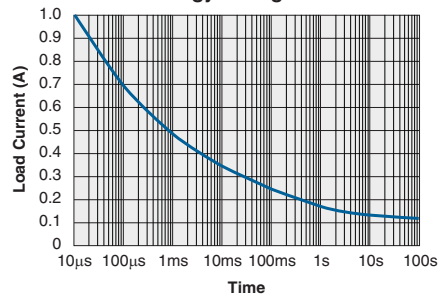
**Typical Blocking Voltage vs. Temperature**



**Typical Leakage vs. Temperature Measured across Pins 4&6**



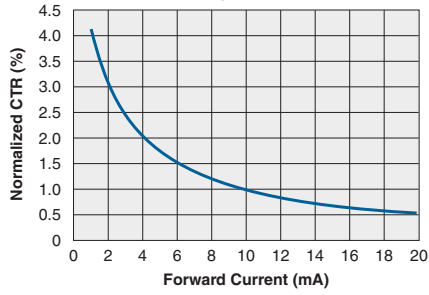
**Energy Rating Curve**



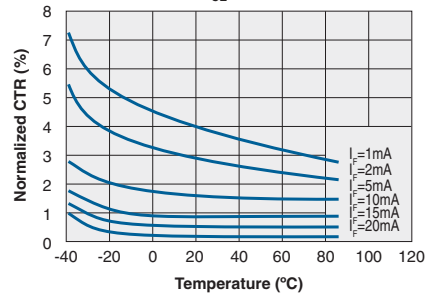
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**PERFORMANCE DATA: DETECTOR**

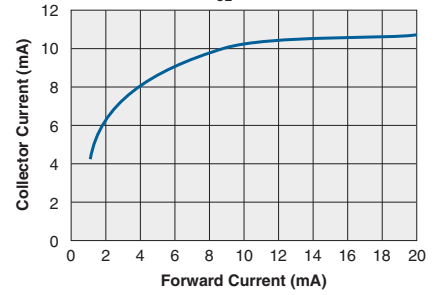
**Typical Normalized CTR vs. Forward Current**  
( $V_{CE}=0.5V$ )



**Typical Normalized CTR vs. Temperature**  
( $V_{CE}=0.5V$ )



**Typical Collector Current vs. Forward Current**  
( $V_{CE}=0.5V$ )



\* The Performance data shown in the graphs above is typical of device performance. For guaranteed parameters not indicated in the written specifications, please contact our application department.

**Manufacturing Information**

**Moisture Sensitivity**



All plastic encapsulated semiconductor packages are susceptible to moisture ingress. Clare classified all of its plastic encapsulated devices for moisture sensitivity according to the latest version of the joint industry standard, **IPC/JEDEC J-STD-020**, in force at the time of product evaluation. We test all of our products to the maximum conditions set forth in the standard, and guarantee proper operation of our devices when handled according to the limitations and information in that standard as well as to any limitations set forth in the information or standards referenced below.

Failure to adhere to the warnings or limitations as established by the listed specifications could result in reduced product performance, reduction of operable life, and/or reduction of overall reliability.

This product carries a **Moisture Sensitivity Level (MSL) rating** as shown below, and should be handled according to the requirements of the latest version of the joint industry standard **IPC/JEDEC J-STD-033**.

Device	Moisture Sensitivity Level (MSL) Rating
XS170 / XS170S	MSL 1

**ESD Sensitivity**



This product is **ESD Sensitive**, and should be handled according to the industry standard **JESD-625**.

**Reflow Profile**

This product has a maximum body temperature and time rating as shown below. All other guidelines of **J-STD-020** must be observed.

Device	Maximum Temperature x Time
XS170 / XS170S	250°C for 30 seconds

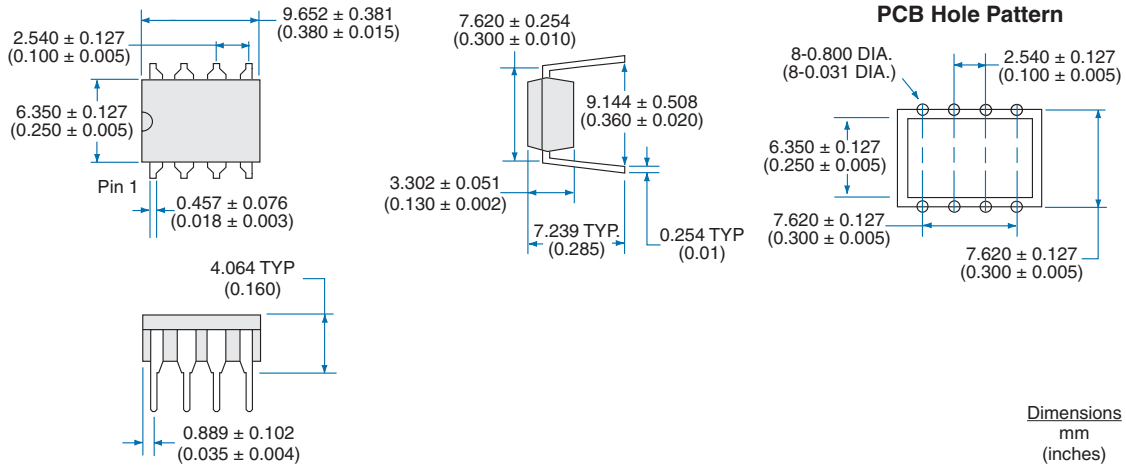
**Board Wash**

Clare recommends the use of no-clean flux formulations. However, board washing to remove flux residue is acceptable. Since Clare employs the use of silicone coating as an optical waveguide in many of its optically isolated products, the use of a short drying bake could be necessary if a wash is used after solder reflow processes. Chlorine- or Fluorine-based solvents or fluxes should not be used. Cleaning methods that employ ultrasonic energy should not be used.

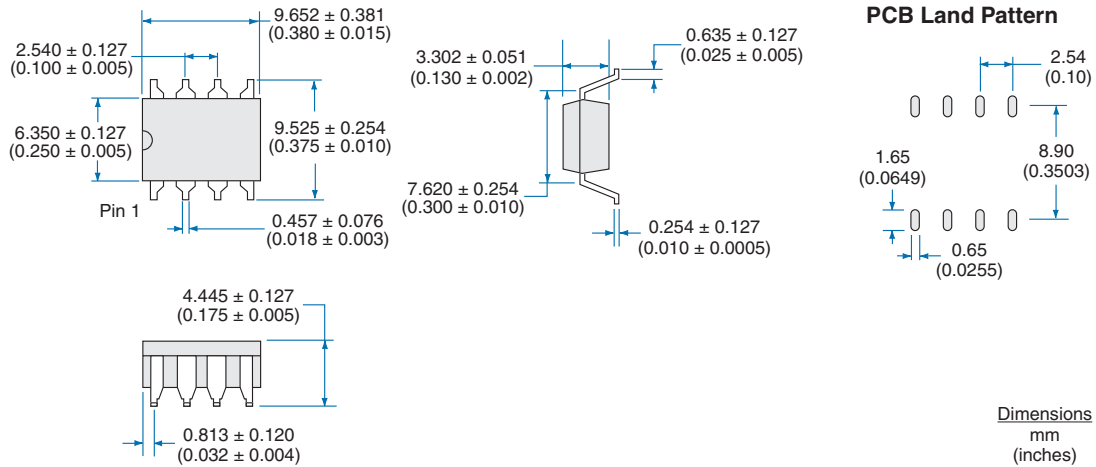


**Mechanical Dimensions**

**XS170**

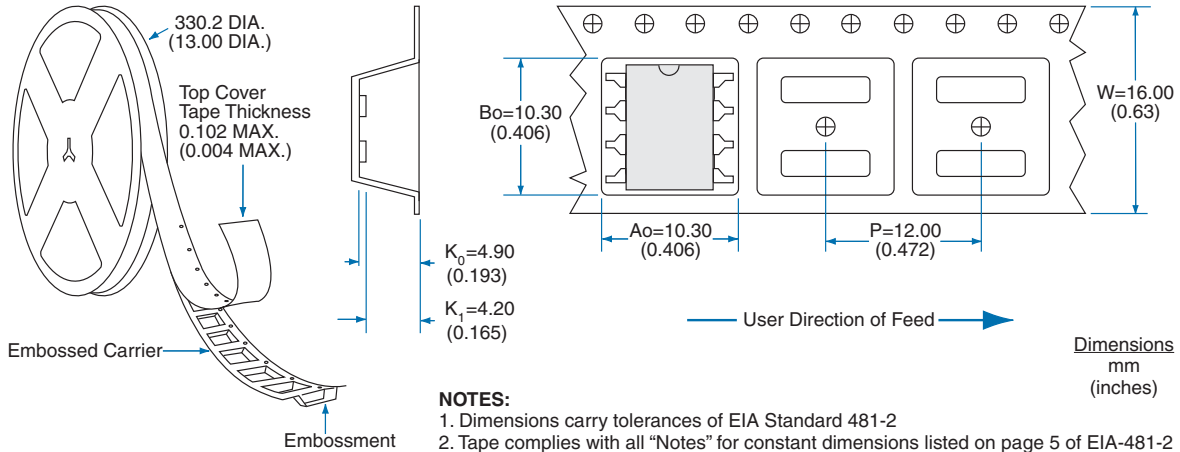


**XS170S**



**Mechanical Dimensions**

**XS170S Tape & Reel**



**For additional information please visit our website at: [www.clare.com](http://www.clare.com)**

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